

Standard Characteristics Example

Standard characteristics described below are just examples of the 7548/7549 Group's characteristics and are not guaranteed. For rated values, refer to "7548 Group Data sheet" and "7549 Group Data sheet".

(1) Power Supply Current Standard Characteristics Example (Vcc-Icc)

Double-speed mode (A/D conversion not executed)
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)

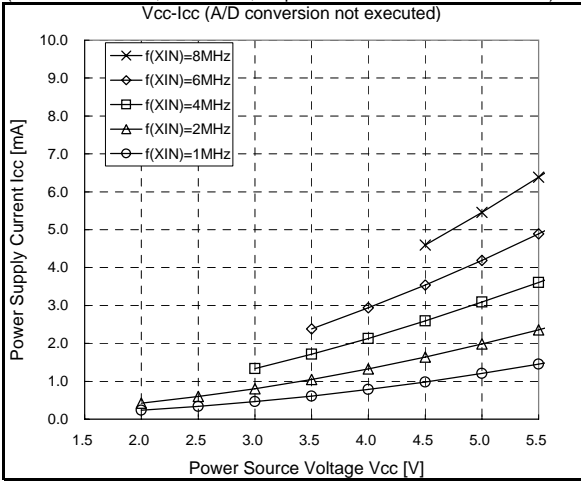


Fig. 1. Vcc-Icc (Double-speed mode)

High-speed mode (A/D conversion not executed)
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)

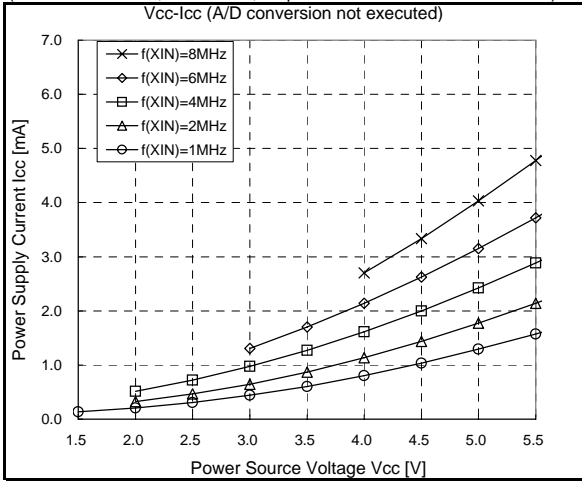


Fig. 2. Vcc-Icc (High-speed mode)

Middle-speed mode (A/D conversion not executed)
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)

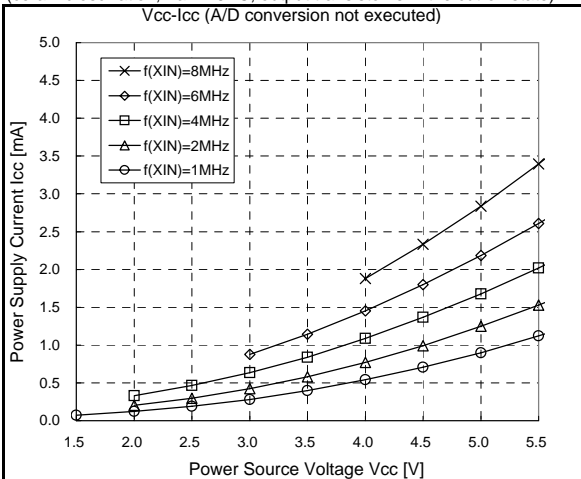


Fig. 3. Vcc-Icc (Middle-speed mode)

Low-speed mode (A/D conversion not executed)
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)

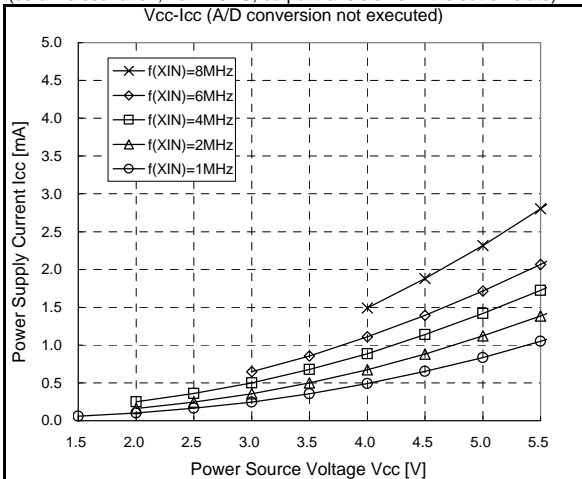


Fig. 4. Vcc-Icc (Low-speed mode)

At WIT instruction executed
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)

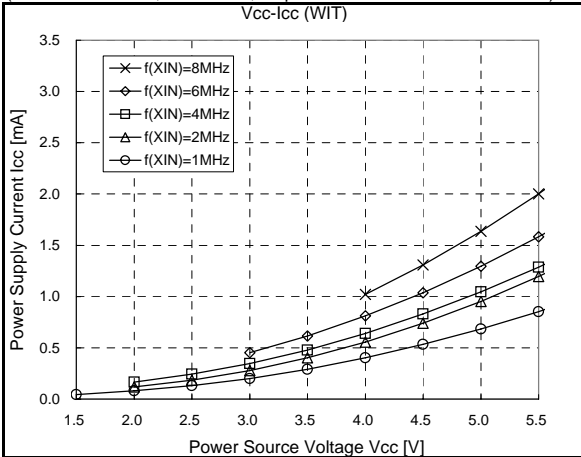


Fig. 5. Vcc-Icc (At WIT instruction executed)

At STP instruction executed
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)

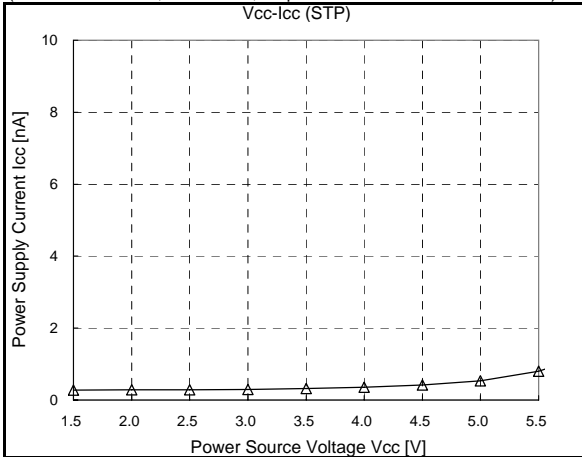


Fig. 6. Vcc-Icc (At STP instruction executed)

At 8 MHz double-speed mode, increment at A/D conversion executed (ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)

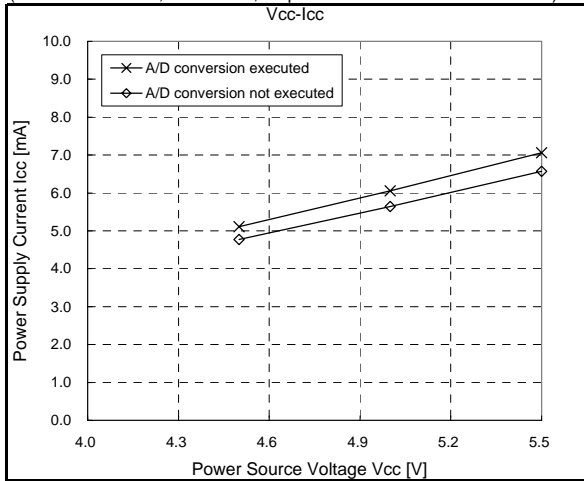


Fig. 7. Vcc-Icc (Increment at A/D conversion executed)

At 8 MHz high-speed mode, increment at A/D conversion executed (ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)

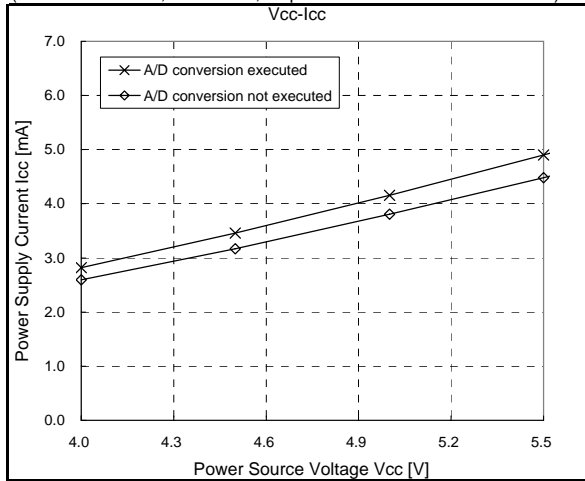


Fig. 8. Vcc-Icc (Increment at A/D conversion executed)

When system is operating in High-speed on-chip oscillator double-speed mode (external oscillation stop, output transistor is in the cut-off state)

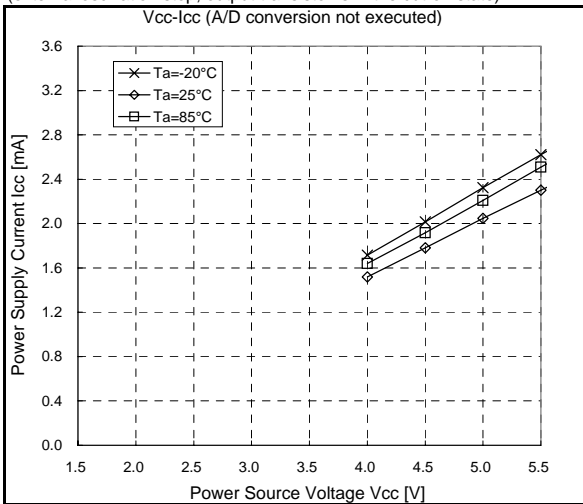


Fig. 9. Vcc-icc (High-speed on-chip oscillator double-speed mode)

When system is operating in High-speed on-chip oscillator high-speed mode (external oscillation stop, output transistor is in the cut-off state)

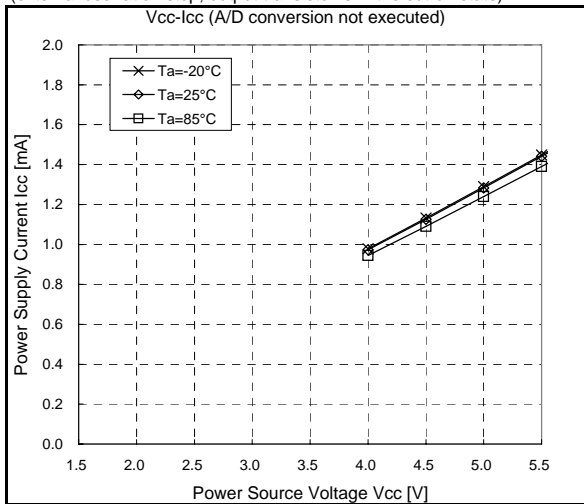


Fig. 10. Vcc-icc (High-speed on-chip oscillator high-speed mode)

When system is operating in High-speed on-chip oscillator middle-speed mode (external oscillation stop, output transistor is in the cut-off state)

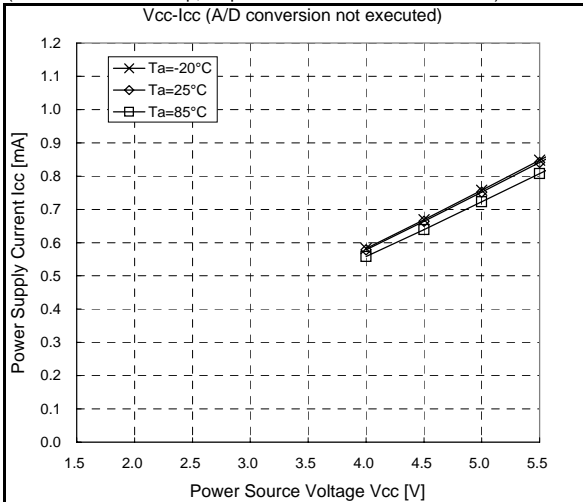


Fig. 11. Vcc-icc (High-speed on-chip oscillator middle-speed mode)

When system is operating in High-speed on-chip oscillator low-speed mode (external oscillation stop, output transistor is in the cut-off state)

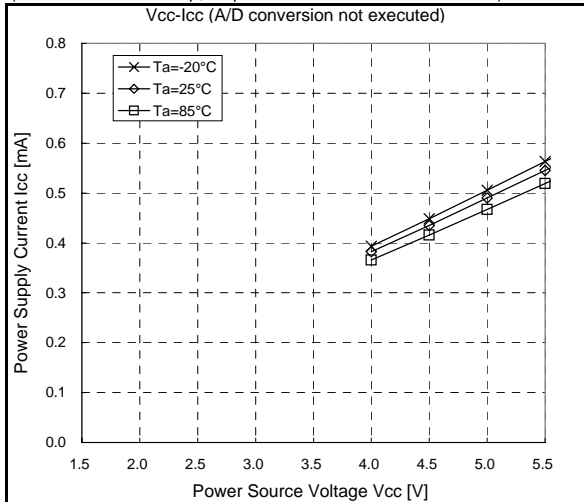


Fig. 12. Vcc-icc (High-speed on-chip oscillator low-speed mode)

High-speed on-chip oscillator operating mode, at WIT instruction executed (external oscillation stop, output transistor is in the cut-off state)

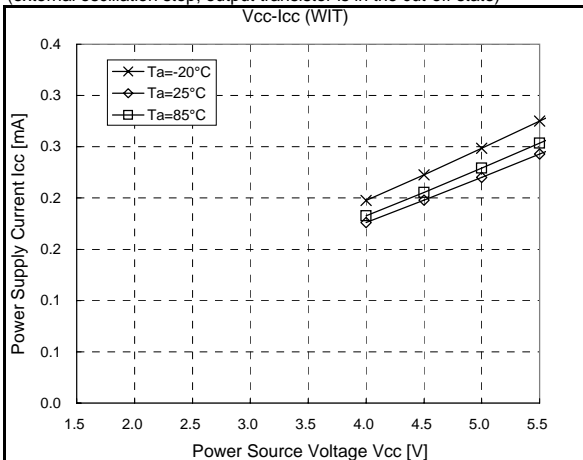


Fig. 13. Vcc-icc (High-speed on-chip oscillator mode at WIT instruction executed)

When system is operating in Low-speed on-chip oscillator double-speed mode (external oscillation stop, output transistor is in the cut-off state)

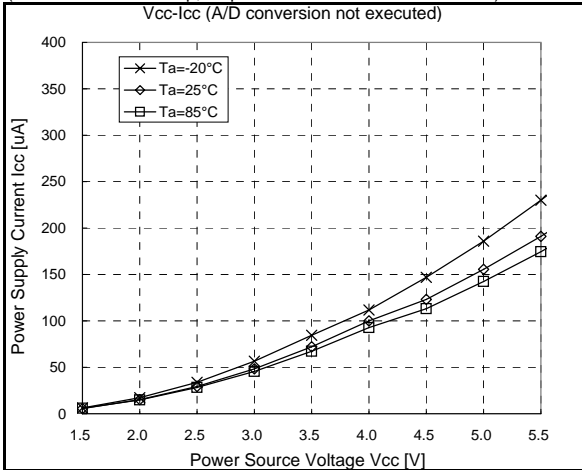


Fig. 14. Vcc-Icc Low-speed on-chip oscillator double-speed mode

When system is operating in Low-speed on-chip oscillator high-speed mode (external oscillation stop, output transistor is in the cut-off state)

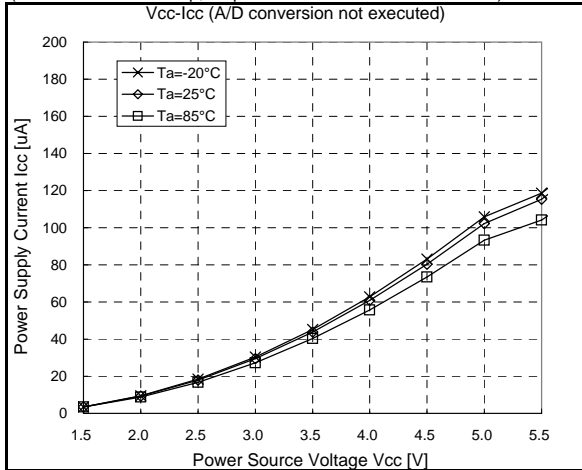


Fig. 15. Vcc-Icc (Low-speed on-chip oscillator high-speed mode)

When system is operating in Low-speed on-chip oscillator middle-speed mode (external oscillation stop, output transistor is in the cut-off state)

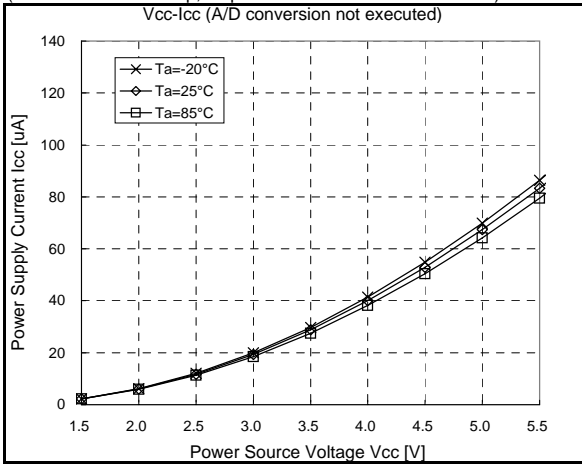


Fig. 16. Vcc-Icc (Low-speed on-chip oscillator middle-speed mode)

When system is operating in Low-speed on-chip oscillator low-speed mode (external oscillation stop, output transistor is in the cut-off state)

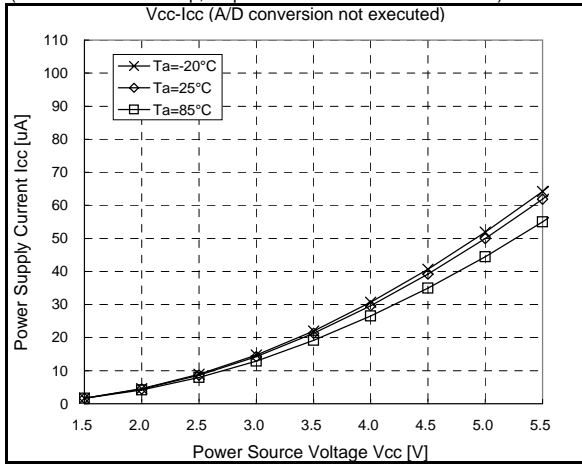


Fig. 17. Vcc-Icc (Low-speed on-chip oscillator low-speed mode)

Low-speed on-chip oscillator operating mode, at WIT instruction executed (external oscillation stop, output transistor is in the cut-off state)

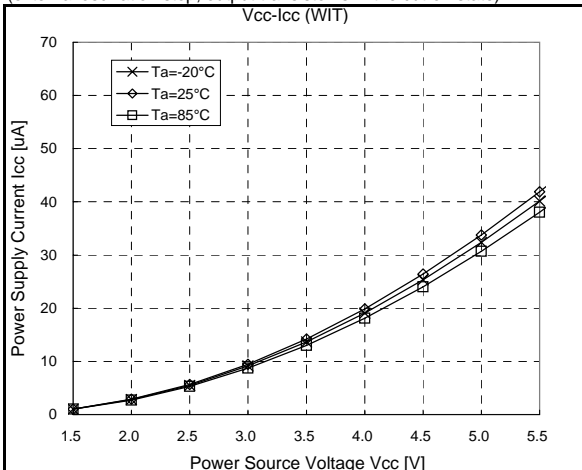


Fig. 18. Vcc-Icc (Low-speed on-chip oscillator mode at WIT instruction executed)

When system is operating in 32kHz quartz-crystal oscillator double-speed mode (internal oscillation stop, output transistor is in the cut-off state)

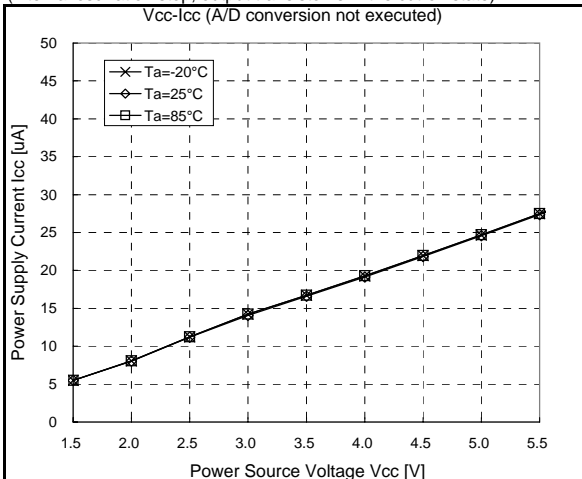


Fig. 19. Vcc-icc (32kHz quartz-crystal oscillator double-speed mode)

When system is operating in 32kHz quartz-crystal oscillator high-speed mode (internal oscillation stop, output transistor is in the cut-off state)

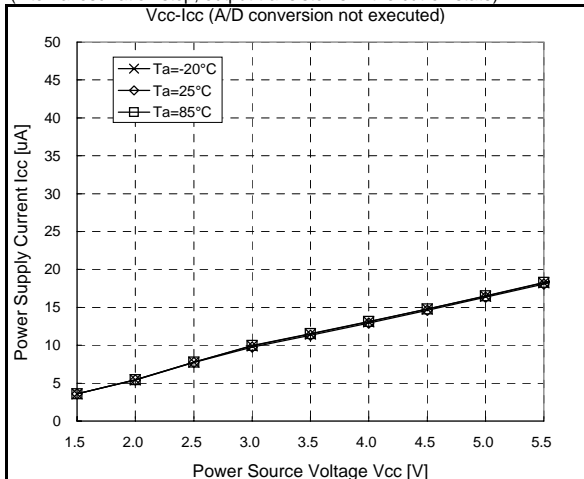


Fig. 20. Vcc-icc (32kHz quartz-crystal oscillator high-speed mode)

When system is operating in 32kHz quartz-crystal oscillator middle-speed mode (internal oscillation stop, output transistor is in the cut-off state)

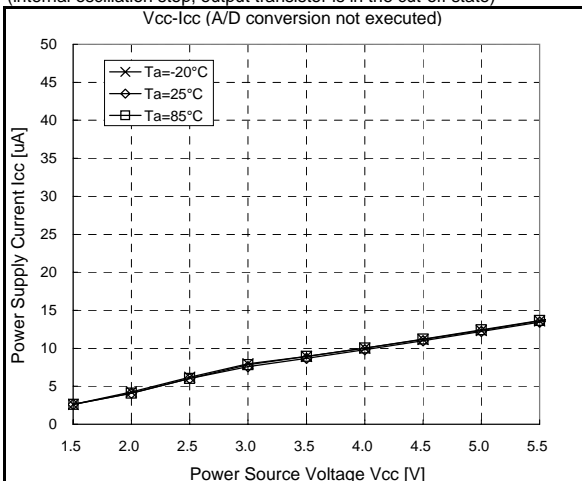


Fig. 21. Vcc-icc (32kHz quartz-crystal oscillator middle-speed mode)

When system is operating in 32kHz quartz-crystal oscillator low-speed mode (internal oscillation stop, output transistor is in the cut-off state)

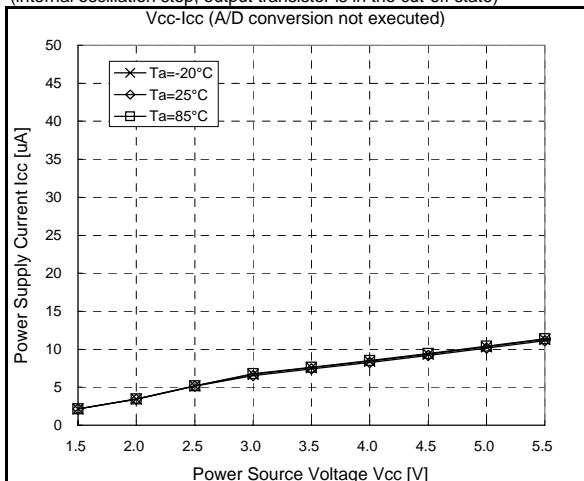


Fig. 22. Vcc-icc (32kHz quartz-crystal oscillator low-speed mode)

32kHz quartz-crystal oscillator operating mode, at WIT instruction executed (internal oscillation stop, output transistor is in the cut-off state)

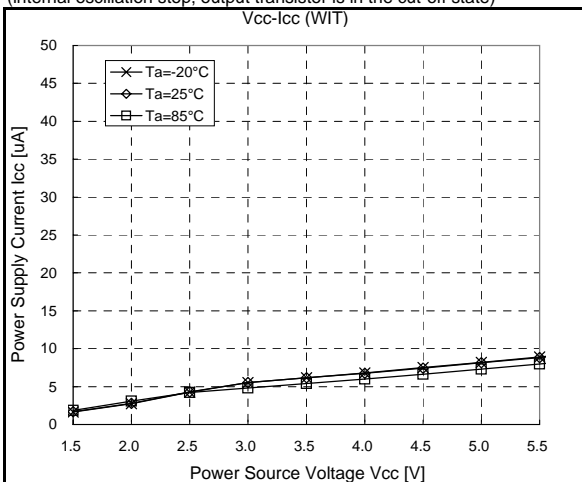


Fig. 23. Vcc-icc (32kHz quartz-crystal oscillator mode at WIT instruction executed)

(2) Power Supply Current Standard Characteristics Example (f(XIN) -Icc)

When system is operating in double-speed mode
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)
f(XIN)-Icc (A/D conversion not executed)

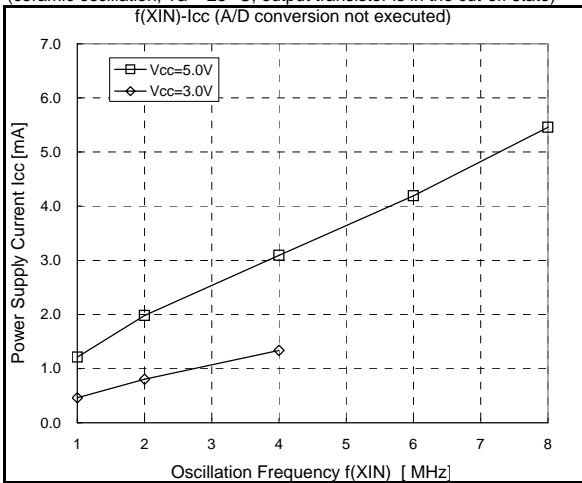


Fig. 24. f(XIN) -Icc (Double-speed mode)

When system is operating in high-speed mode
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)
f(XIN)-Icc (A/D conversion not executed)

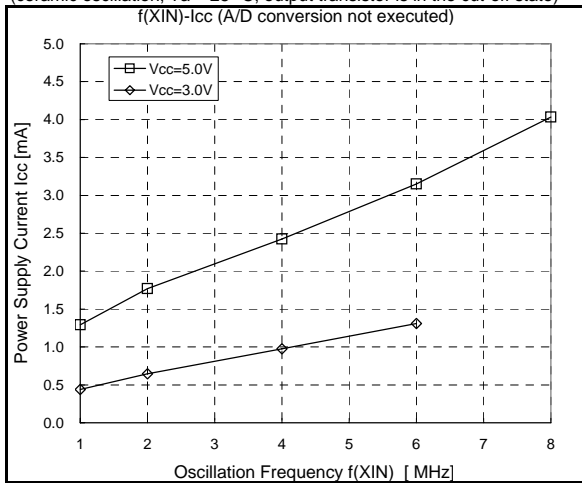


Fig. 25. f(XIN) -Icc (High-speed mode)

When system is operating in middle-speed mode
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)
f(XIN)-Icc (A/D conversion not executed)

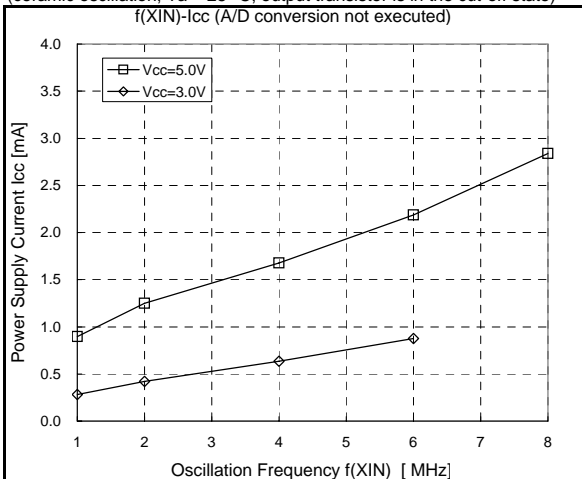


Fig. 26. f(XIN) -Icc (Middle-speed mode)

When system is operating in low-speed mode
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)
f(XIN)-Icc (A/D conversion not executed)

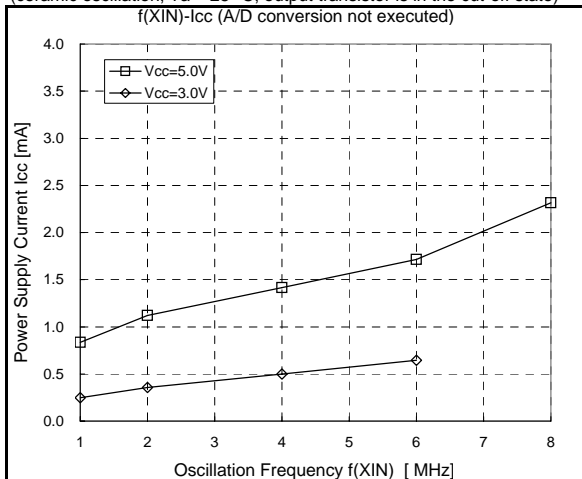


Fig. 27. f(XIN) -Icc (Low-speed mode)

At WIT instruction executed
(ceramic oscillation, Ta = 25 °C, output transistor is in the cut-off state)
f(XIN)-Icc (WIT)

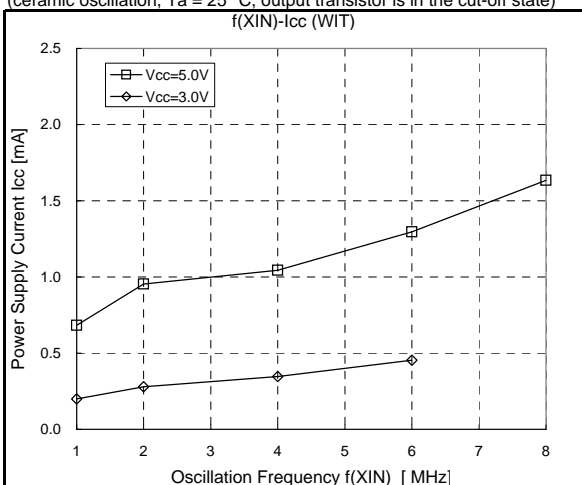


Fig. 28. f(XIN) -Icc (At WIT instruction executed)

(3) Power Supply Current Standard Characteristics Example (Ta-Icc)

When system is operating in High-speed on-chip oscillator double-speed mode (external oscillation stop, output transistor is in the cut-off state)

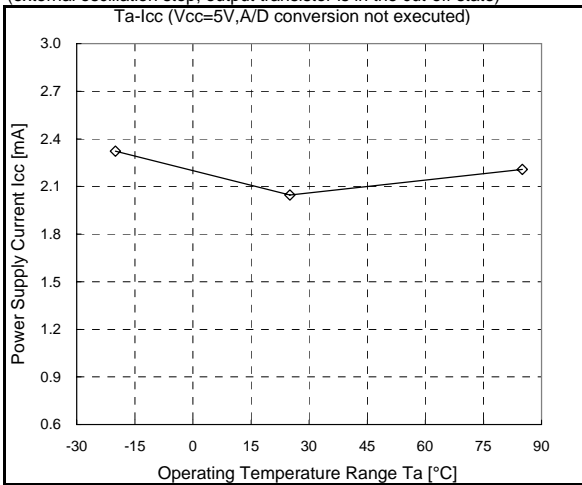


Fig. 29. Ta-Icc (High-speed on-chip oscillator double-speed mode)

When system is operating in High-speed on-chip oscillator high-speed mode (external oscillation stop, output transistor is in the cut-off state)

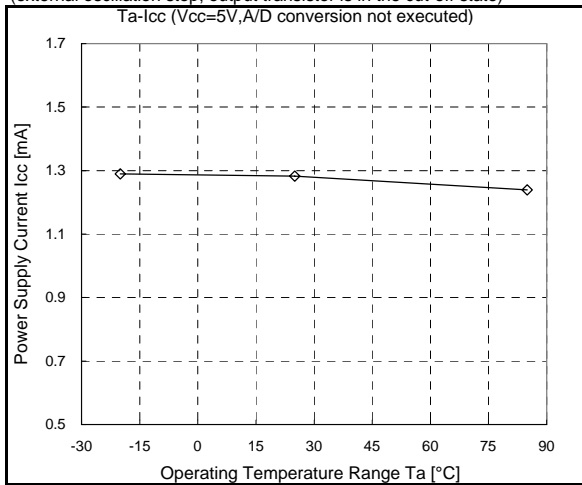


Fig. 30. Ta-Icc (High-speed on-chip oscillator high-speed mode)

When system is operating in High-speed on-chip oscillator middle-speed mode (external oscillation stop, output transistor is in the cut-off state)

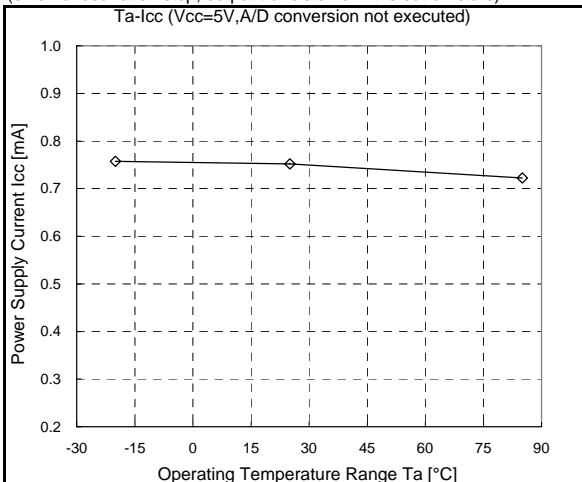


Fig. 31. Ta-Icc (High-speed on-chip oscillator middle-speed mode)

When system is operating in High-speed on-chip oscillator low-speed mode (external oscillation stop, output transistor is in the cut-off state)

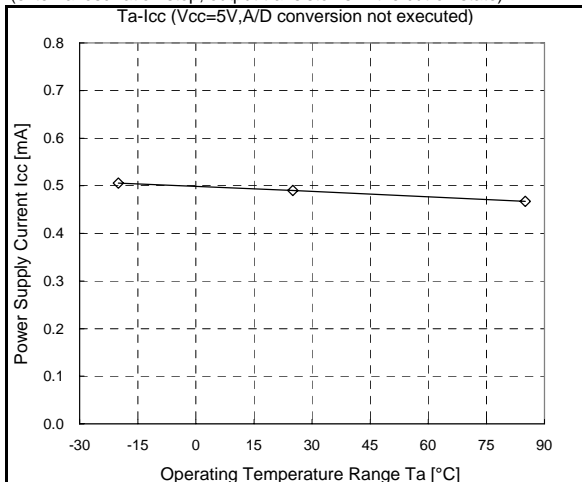


Fig. 32. Ta-Icc (High-speed on-chip oscillator low-speed mode)

High-speed on-chip oscillator operating mode at WIT instruction executed (external oscillation stop, output transistor is in the cut-off state)

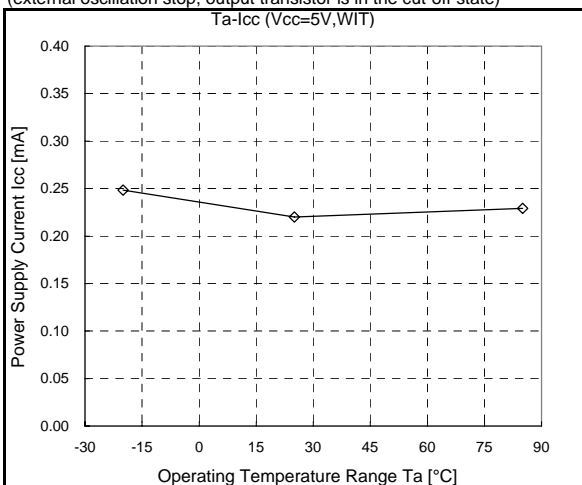


Fig. 33. Ta-Icc (High-speed on-chip oscillator mode at WIT instruction executed)

When system is operating in Low-speed on-chip oscillator double-speed mode (external oscillation stop, output transistor is in the cut-off state)

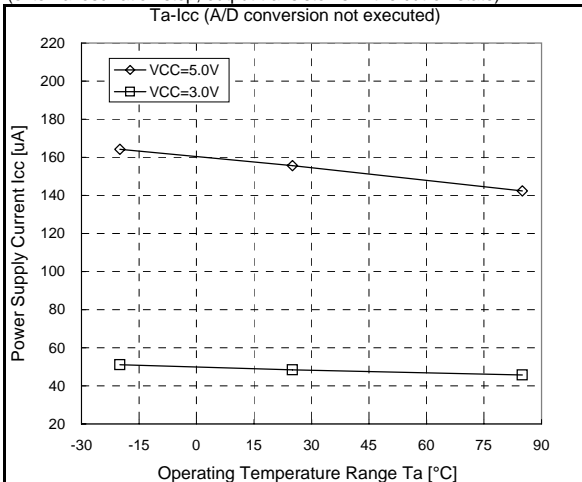


Fig. 34. Ta-Icc (Low-speed on-chip oscillator double-speed mode)

When system is operating in Low-speed on-chip oscillator high-speed mode (external oscillation stop, output transistor is in the cut-off state)

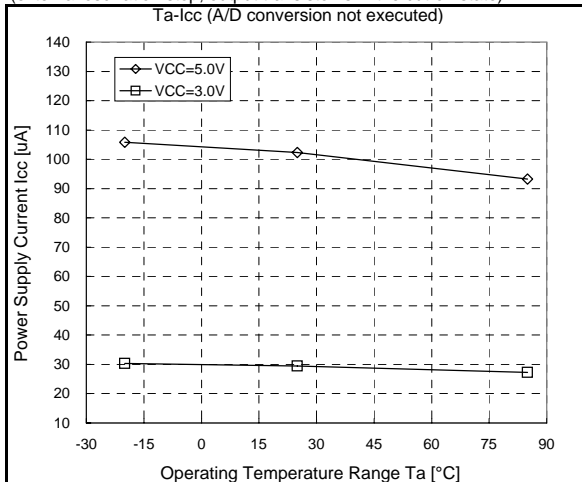


Fig. 35. Ta-Icc (Low-speed on-chip oscillator high-speed mode)

When system is operating in Low-speed on-chip oscillator middle-speed mode (external oscillation stop, output transistor is in the cut-off state)

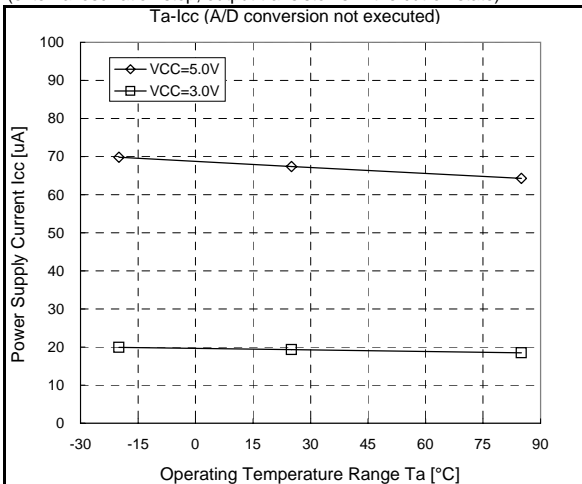


Fig. 36. Ta-Icc (Low-speed on-chip oscillator middle-speed mode)

When system is operating in Low-speed on-chip oscillator low-speed mode (external oscillation stop, output transistor is in the cut-off state)

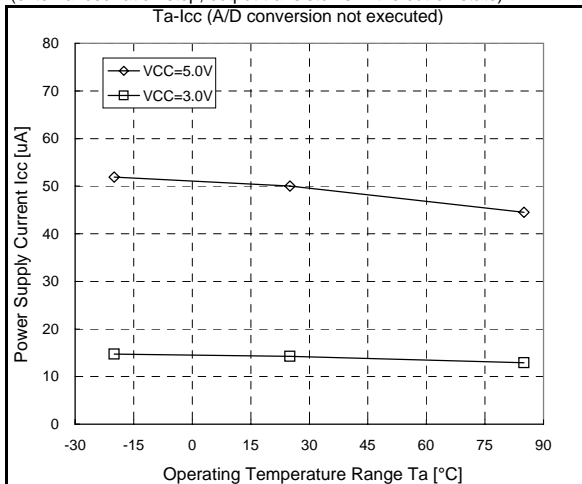


Fig. 37. Ta-Icc (Low-speed on-chip oscillator low-speed mode)

low-speed on-chip oscillator operating mode at WIT instruction executed (external oscillation stop, output transistor is in the cut-off state)

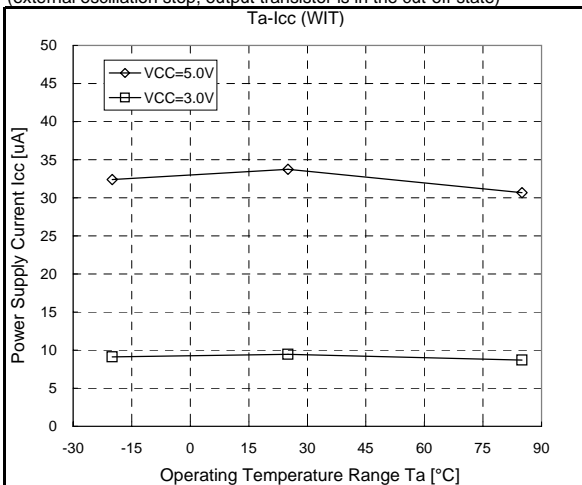


Fig. 38. Ta-Icc (Low-speed on-chip oscillator mode at WIT instruction executed)

When system is operating in 32kHz quartz-crystal oscillator double-speed mode (internal oscillation stop, output transistor is in the cut-off state)

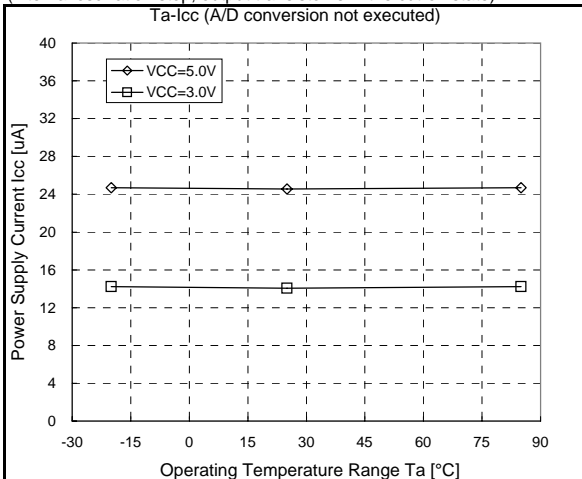


Fig. 39. Ta-icc (32kHz quartz-crystal oscillator double-speed mode)

When system is operating in 32kHz quartz-crystal oscillator high-speed mode (internal oscillation stop, output transistor is in the cut-off state)

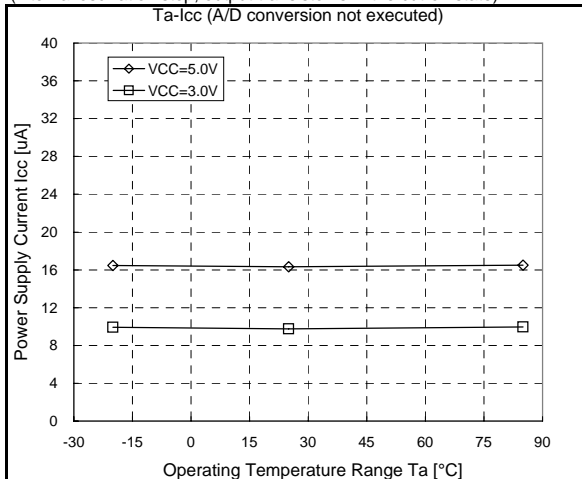


Fig. 40. Ta-icc (32kHz quartz-crystal oscillator high-speed mode)

When system is operating in 32kHz quartz-crystal oscillator middle-speed mode (internal oscillation stop, output transistor is in the cut-off state)

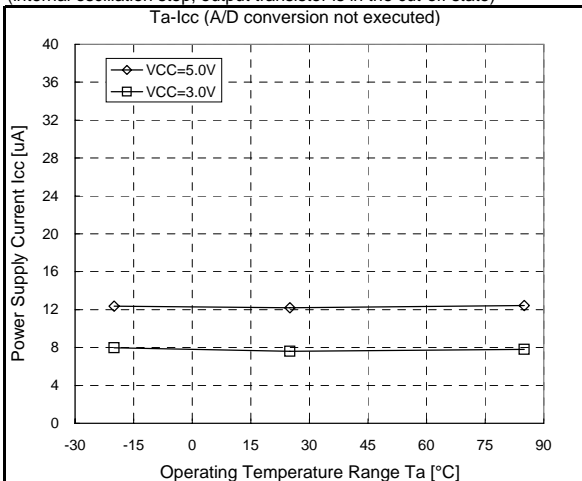


Fig. 41. Ta-icc (32kHz quartz-crystal oscillator middle-speed mode)

When system is operating in 32kHz quartz-crystal oscillator low-speed mode (internal oscillation stop, output transistor is in the cut-off state)

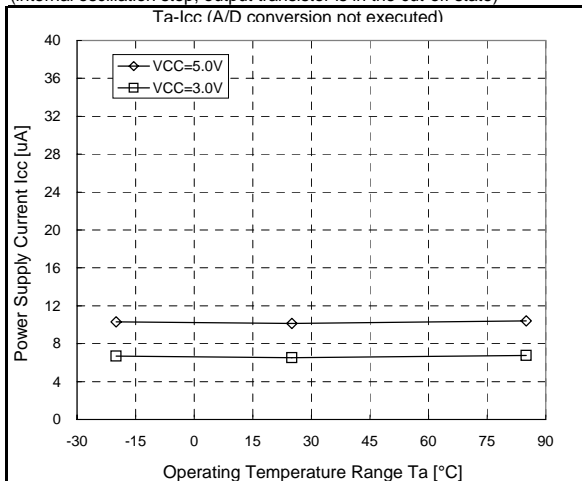


Fig. 42. Ta-icc (32kHz quartz-crystal oscillator low-speed mode)

32kHz quartz-crystal oscillator operating mode at WIT instruction executed (internal oscillation stop, output transistor is in the cut-off state)

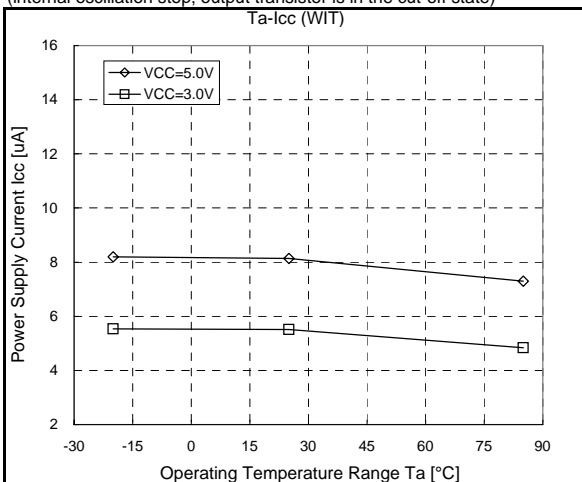


Fig. 43. Ta-icc (32kHz quartz-crystal oscillator mode at WIT instruction executed)

(4) Port Standard characteristics Example (VOH-IOH)

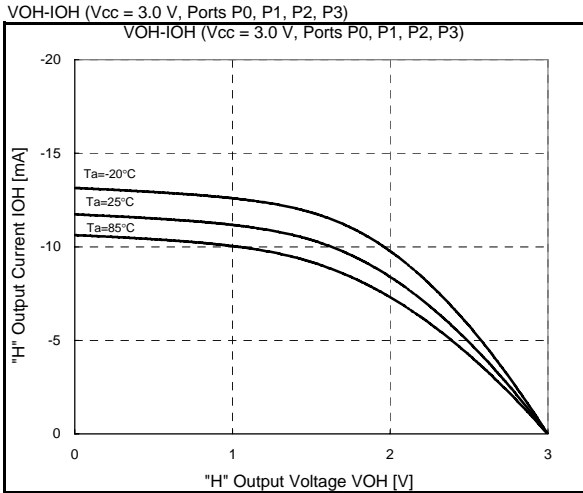


Fig. 44.VOH-IOH (Vcc = 3.0 V, Ports P0, P1, P2, P3)

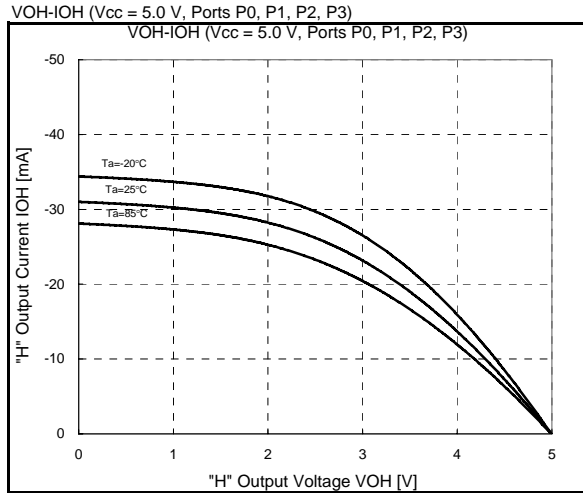


Fig. 45.VOH-IOH (Vcc = 5.0 V, Ports P0, P1, P2, P3)

(5) Port Standard Characteristics Example (VOL-IOL)

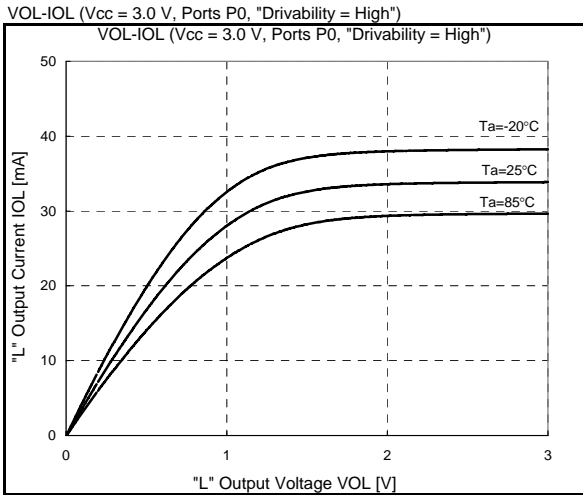


Fig. 46.VOL-IOL
(Vcc = 3.0 V, Ports P0, "Drivability = High")

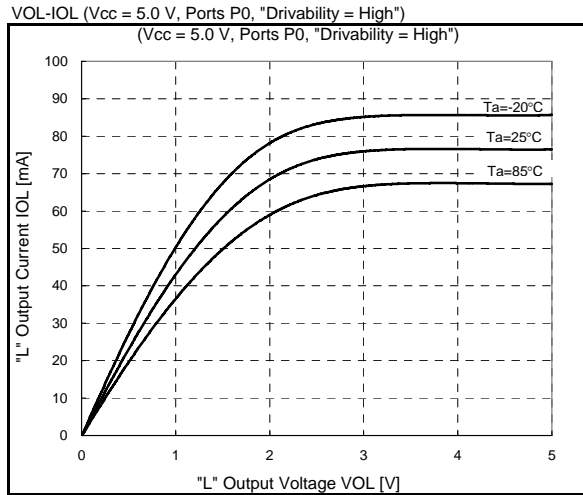


Fig. 47.VOL-IOL
(Vcc = 5.0 V, Ports P0, "Drivability = High")

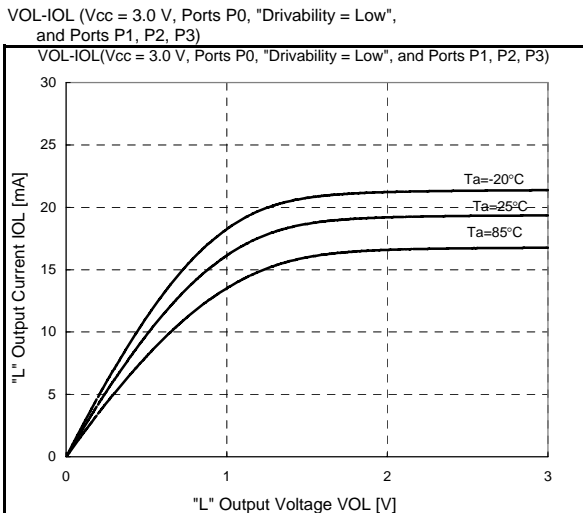


Fig. 48.VOL-IOL
(Vcc = 3.0 V, Ports P0, "Drivability = Low", and Ports P1, P2, P3)

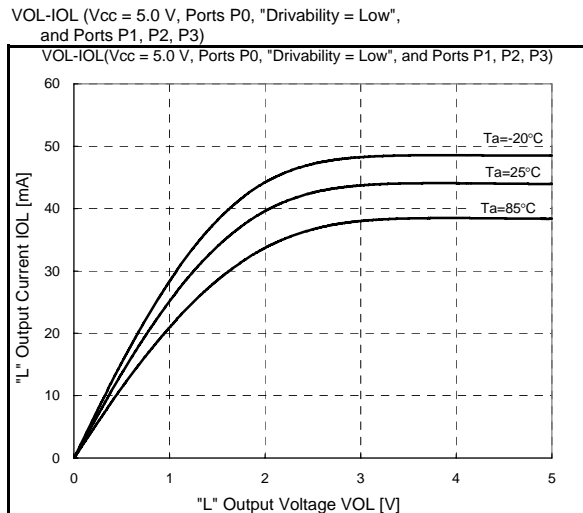


Fig. 49.VOL-IOL
(Vcc = 5.0 V, Ports P0, "Drivability = Low", and Ports P1, P2, P3)

(6) Port Standard Characteristics Example (Vcc-IIL)

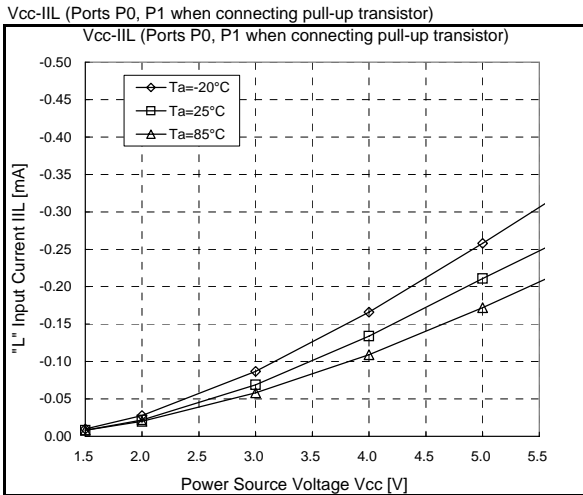


Fig. 50.Vcc-IIL (Ports P0, P1 when connecting pull-up transistor)

(7) Port Standard Characteristics Example (Vcc-VIHL)

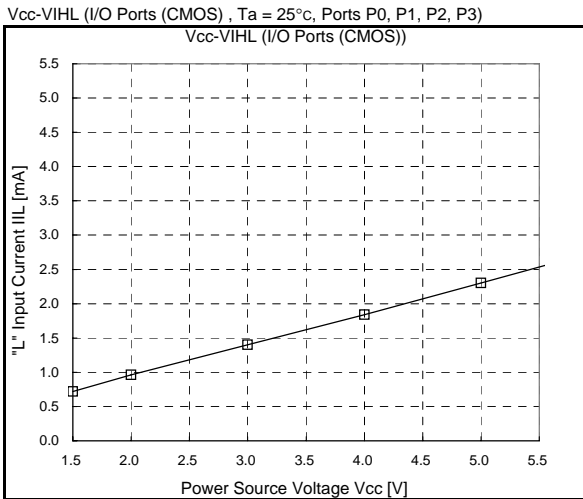


Fig. 51.Vcc-VIHL (I/O Ports (CMOS))

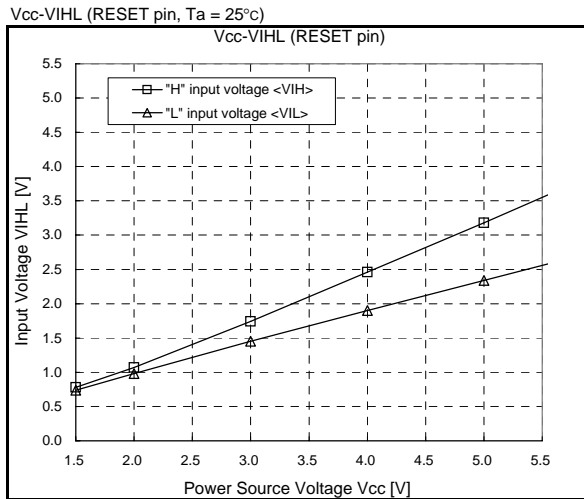


Fig. 52.Vcc-VIHL (RESET pin)

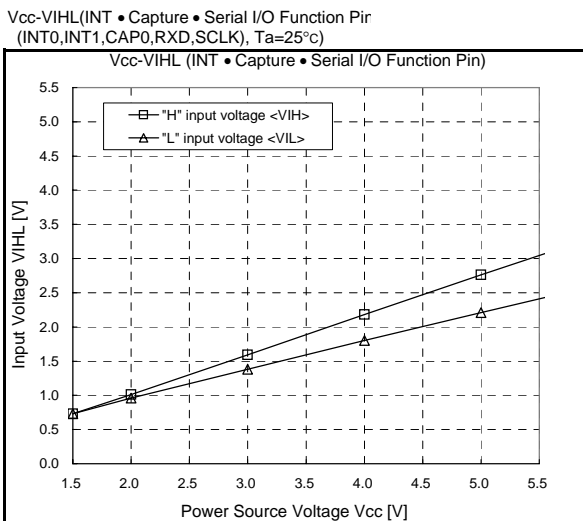


Fig. 53.Vcc-VIHL (INT • Capture • Serial I/O Function Pin)

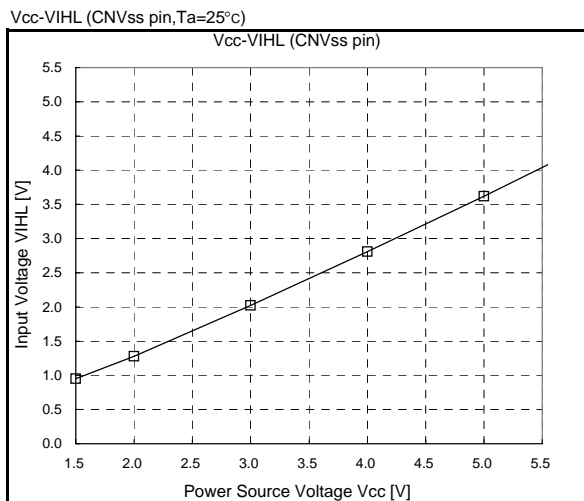


Fig. 54.Vcc-VIHL (CNVss pin)

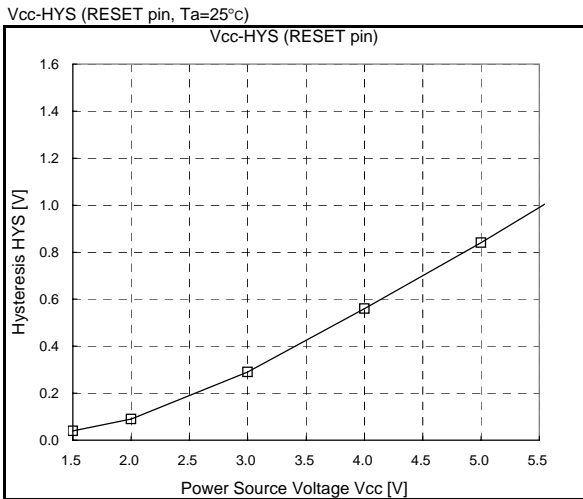


Fig. 55.Vcc-HYS (RESET pin)

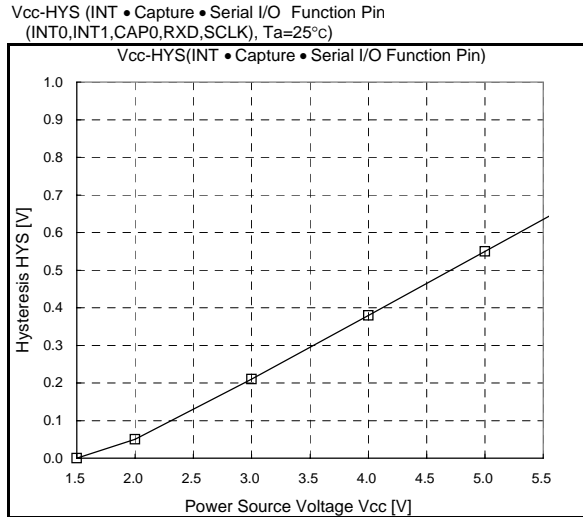


Fig. 56.Vcc-HYS(INT • Capture • Serial I/O Function Pin)

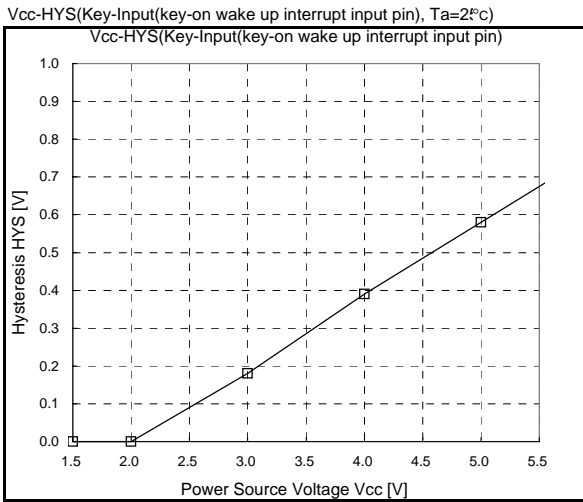


Fig. 57.Vcc-HYS(Key-Input(key-on wake up interrupt input pin))

(8) Port Standard Characteristics Example (VIN-II (AD))

VIN-II (AD) (A/D converter operation, $f(Xin) = 8$ MHz, Double-speed mode
 $V_{cc} = 5.0$ V, $T_a = 25^\circ\text{C}$)

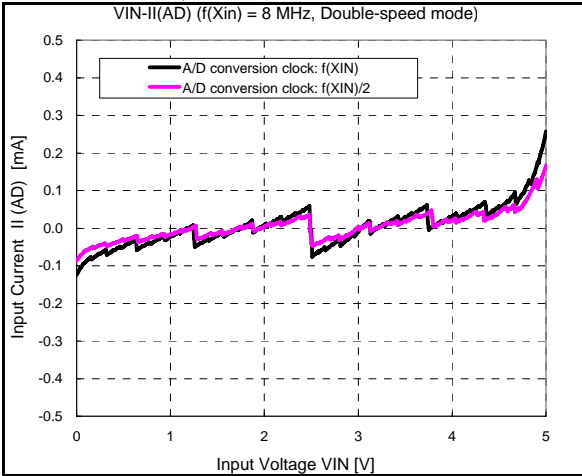


Fig. 58.VIN-II (AD) ($f(Xin) = 8$ MHz Double-speed mode)

VIN-II (AD) (A/D converter operation, $f(Xin) = 6$ MHz, Double-speed mode,
 $V_{cc} = 5.0$ V, $T_a = 25^\circ\text{C}$)

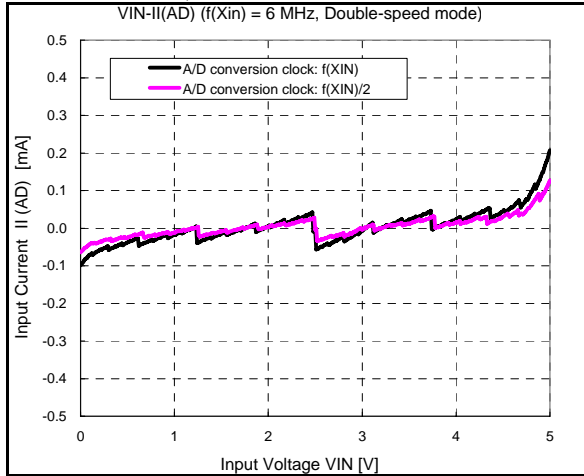


Fig. 59.VIN-II(AD) ($f(Xin) = 6$ MHz Double-speed mode)

VIN-II (AD) (A/D converter operation, $f(Xin) = 4$ MHz, Double-speed mode,
 $V_{cc} = 5.0$ V, $T_a = 25^\circ\text{C}$)

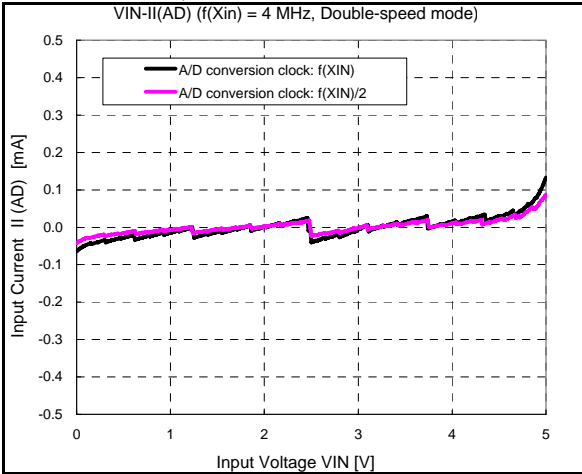


Fig. 60.VIN-II (AD) ($f(Xin) = 4$ MHz Double-speed mode)

(9) High-speed on-chip Oscillator Frequency Characteristics Example

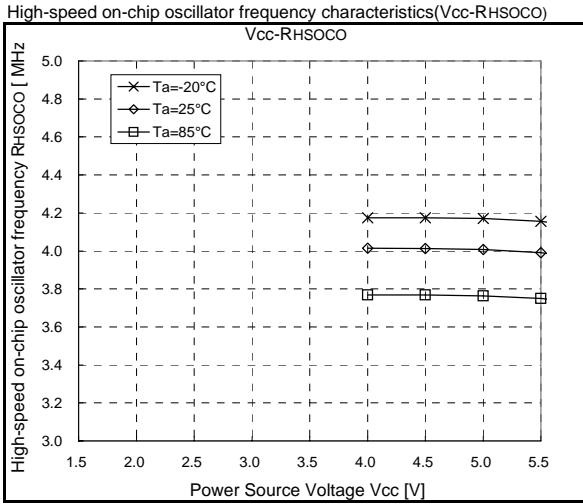


Fig. 61. Vcc-RHSOCO

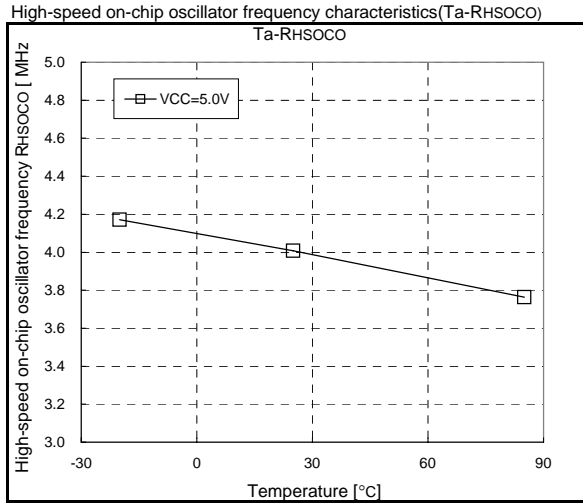


Fig. 62. Ta-RHSOCO

(10) Low-speed on-chip Oscillator Frequency Characteristics Example

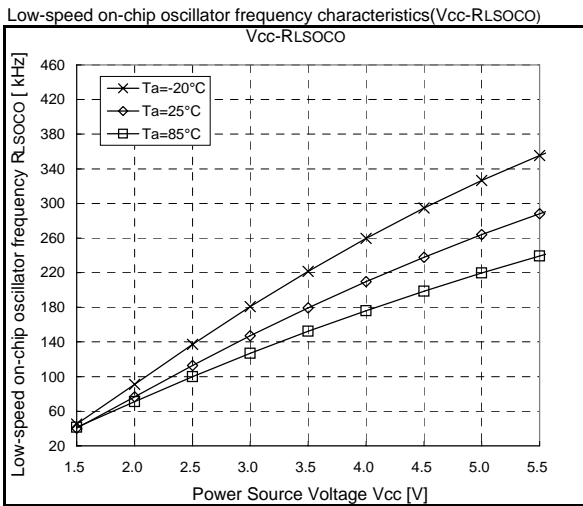


Fig. 63. Vcc-RLSOCO

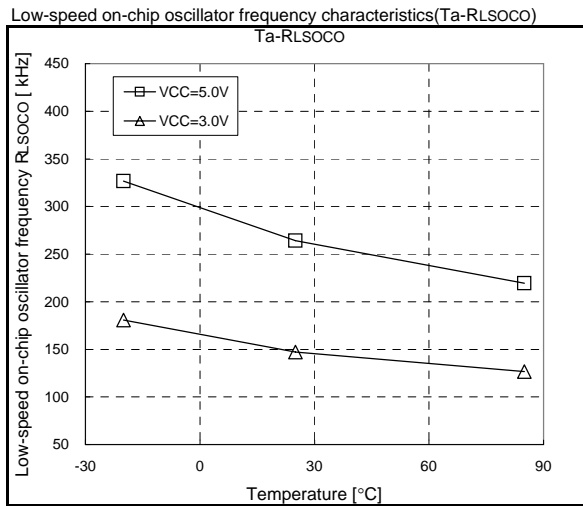


Fig. 64. Ta-RLSOCO

(11) A/D Conversion Accuracy Characteristics
A/D conversion accuracy standard characteristics example-1

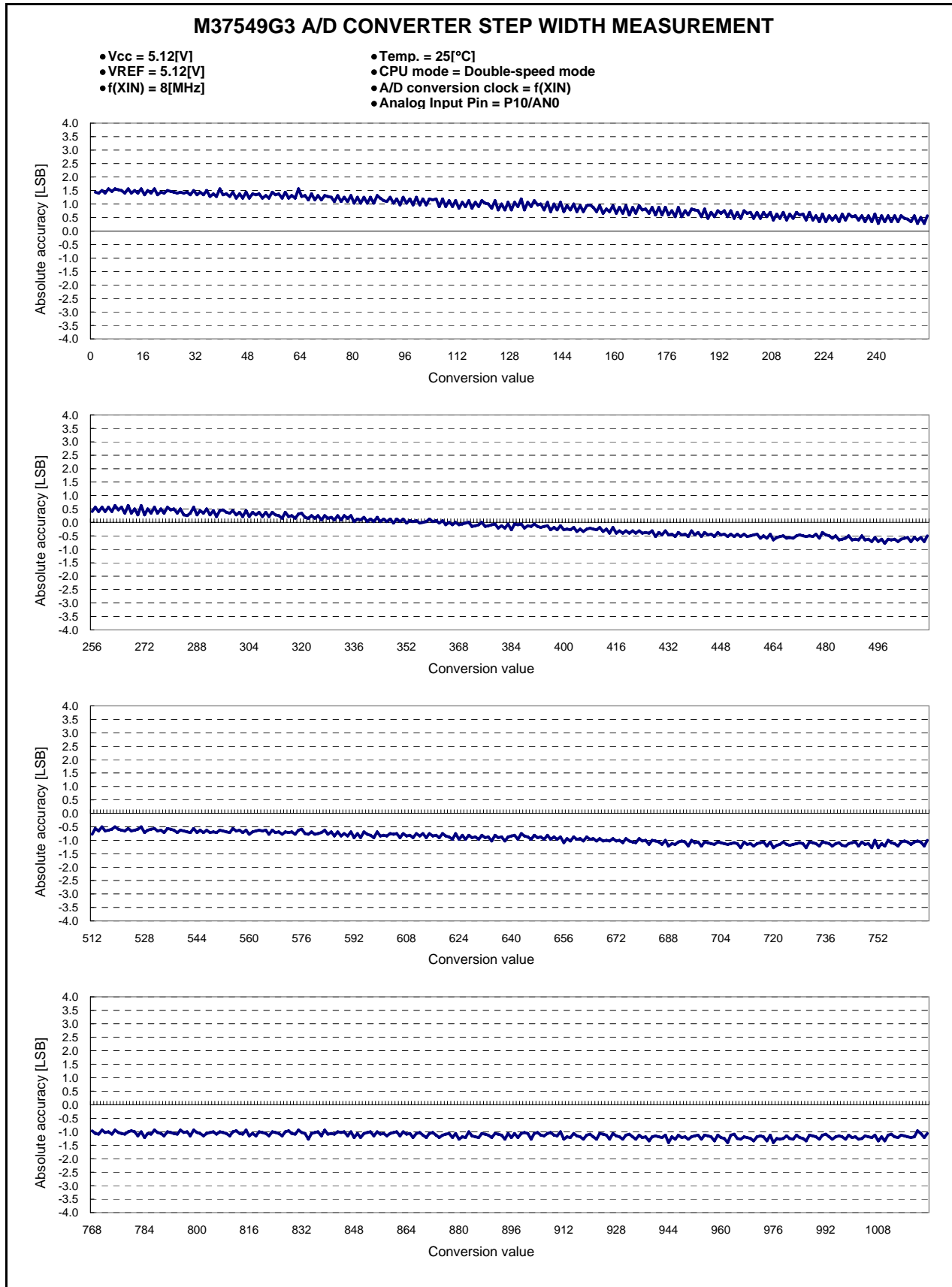


Fig. 65. A/D conversion accuracy standard characteristics example-1

A/D conversion accuracy standard characteristics example-2

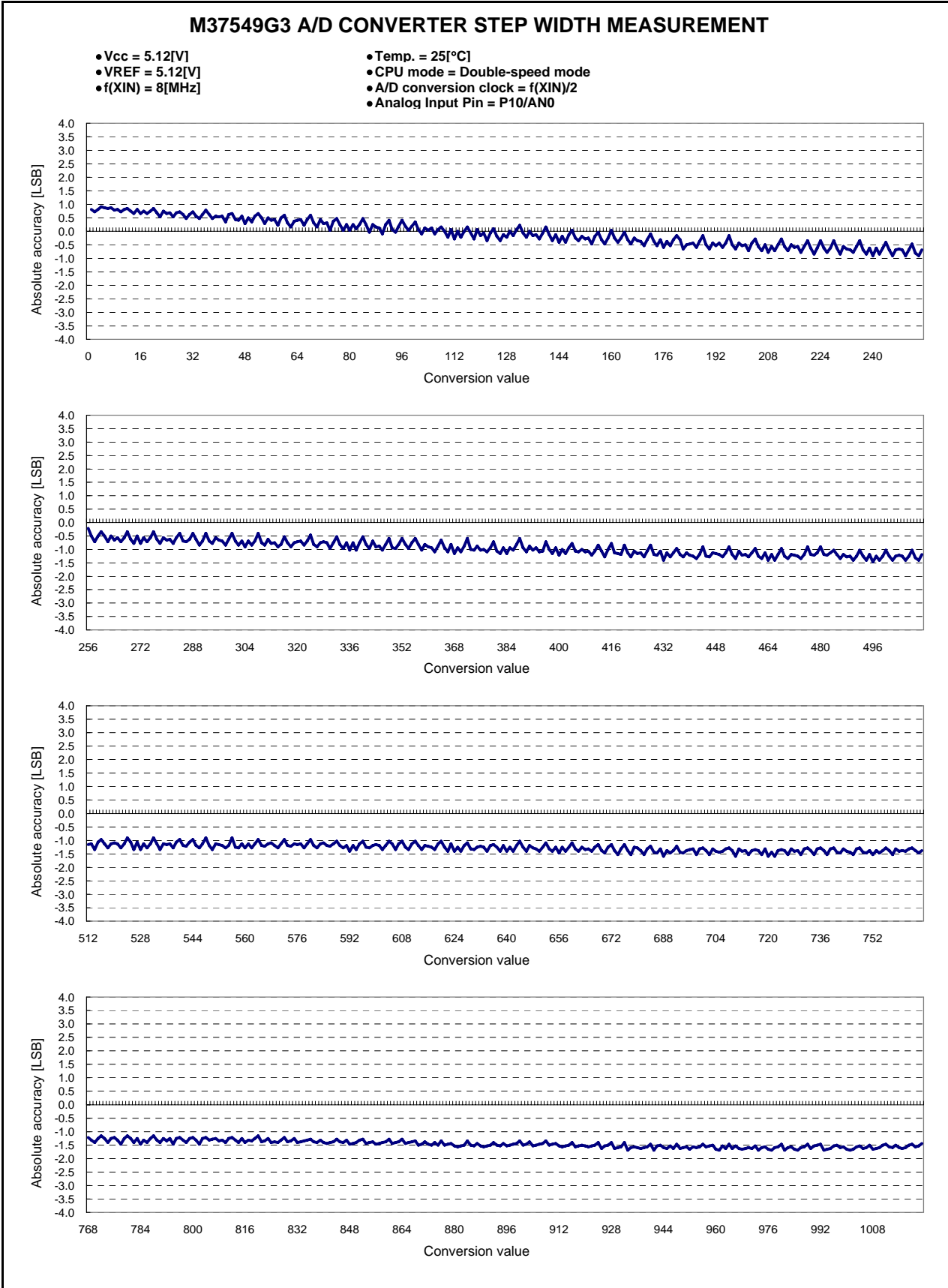


Fig. 66. A/D conversion accuracy standard characteristics example-2

To our customers,

Old Company Name in Catalogs and Other Documents

On April 1st, 2010, NEC Electronics Corporation merged with Renesas Technology Corporation, and Renesas Electronics Corporation took over all the business of both companies. Therefore, although the old company name remains in this document, it is a valid Renesas Electronics document. We appreciate your understanding.

Renesas Electronics website: <http://www.renesas.com>

April 1st, 2010
Renesas Electronics Corporation

Issued by: Renesas Electronics Corporation (<http://www.renesas.com>)

Send any inquiries to <http://www.renesas.com/inquiry>.

Notice

1. All information included in this document is current as of the date this document is issued. Such information, however, is subject to change without any prior notice. Before purchasing or using any Renesas Electronics products listed herein, please confirm the latest product information with a Renesas Electronics sales office. Also, please pay regular and careful attention to additional and different information to be disclosed by Renesas Electronics such as that disclosed through our website.
2. Renesas Electronics does not assume any liability for infringement of patents, copyrights, or other intellectual property rights of third parties by or arising from the use of Renesas Electronics products or technical information described in this document. No license, express, implied or otherwise, is granted hereby under any patents, copyrights or other intellectual property rights of Renesas Electronics or others.
3. You should not alter, modify, copy, or otherwise misappropriate any Renesas Electronics product, whether in whole or in part.
4. Descriptions of circuits, software and other related information in this document are provided only to illustrate the operation of semiconductor products and application examples. You are fully responsible for the incorporation of these circuits, software, and information in the design of your equipment. Renesas Electronics assumes no responsibility for any losses incurred by you or third parties arising from the use of these circuits, software, or information.
5. When exporting the products or technology described in this document, you should comply with the applicable export control laws and regulations and follow the procedures required by such laws and regulations. You should not use Renesas Electronics products or the technology described in this document for any purpose relating to military applications or use by the military, including but not limited to the development of weapons of mass destruction. Renesas Electronics products and technology may not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable domestic or foreign laws or regulations.
6. Renesas Electronics has used reasonable care in preparing the information included in this document, but Renesas Electronics does not warrant that such information is error free. Renesas Electronics assumes no liability whatsoever for any damages incurred by you resulting from errors in or omissions from the information included herein.
7. Renesas Electronics products are classified according to the following three quality grades: “Standard”, “High Quality”, and “Specific”. The recommended applications for each Renesas Electronics product depends on the product’s quality grade, as indicated below. You must check the quality grade of each Renesas Electronics product before using it in a particular application. You may not use any Renesas Electronics product for any application categorized as “Specific” without the prior written consent of Renesas Electronics. Further, you may not use any Renesas Electronics product for any application for which it is not intended without the prior written consent of Renesas Electronics. Renesas Electronics shall not be in any way liable for any damages or losses incurred by you or third parties arising from the use of any Renesas Electronics product for an application categorized as “Specific” or for which the product is not intended where you have failed to obtain the prior written consent of Renesas Electronics. The quality grade of each Renesas Electronics product is “Standard” unless otherwise expressly specified in a Renesas Electronics data sheets or data books, etc.
 - “Standard”: Computers; office equipment; communications equipment; test and measurement equipment; audio and visual equipment; home electronic appliances; machine tools; personal electronic equipment; and industrial robots.
 - “High Quality”: Transportation equipment (automobiles, trains, ships, etc.); traffic control systems; anti-disaster systems; anti-crime systems; safety equipment; and medical equipment not specifically designed for life support.
 - “Specific”: Aircraft; aerospace equipment; submersible repeaters; nuclear reactor control systems; medical equipment or systems for life support (e.g. artificial life support devices or systems), surgical implantations, or healthcare intervention (e.g. excision, etc.), and any other applications or purposes that pose a direct threat to human life.
8. You should use the Renesas Electronics products described in this document within the range specified by Renesas Electronics, especially with respect to the maximum rating, operating supply voltage range, movement power voltage range, heat radiation characteristics, installation and other product characteristics. Renesas Electronics shall have no liability for malfunctions or damages arising out of the use of Renesas Electronics products beyond such specified ranges.
9. Although Renesas Electronics endeavors to improve the quality and reliability of its products, semiconductor products have specific characteristics such as the occurrence of failure at a certain rate and malfunctions under certain use conditions. Further, Renesas Electronics products are not subject to radiation resistance design. Please be sure to implement safety measures to guard them against the possibility of physical injury, and injury or damage caused by fire in the event of the failure of a Renesas Electronics product, such as safety design for hardware and software including but not limited to redundancy, fire control and malfunction prevention, appropriate treatment for aging degradation or any other appropriate measures. Because the evaluation of microcomputer software alone is very difficult, please evaluate the safety of the final products or system manufactured by you.
10. Please contact a Renesas Electronics sales office for details as to environmental matters such as the environmental compatibility of each Renesas Electronics product. Please use Renesas Electronics products in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. Renesas Electronics assumes no liability for damages or losses occurring as a result of your noncompliance with applicable laws and regulations.
11. This document may not be reproduced or duplicated, in any form, in whole or in part, without prior written consent of Renesas Electronics.
12. Please contact a Renesas Electronics sales office if you have any questions regarding the information contained in this document or Renesas Electronics products, or if you have any other inquiries.

(Note 1) “Renesas Electronics” as used in this document means Renesas Electronics Corporation and also includes its majority-owned subsidiaries.

(Note 2) “Renesas Electronics product(s)” means any product developed or manufactured by or for Renesas Electronics.